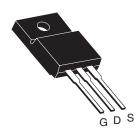


STP36NF06FP-VB Datasheet N-Channel 60 V (D-S) MOSFET

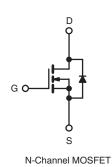
PRODUCT SUMMARY					
V _{DS} (V)	60				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.027			
Q _g (Max.) (nC)	95				
Q _{gs} (nC)	27				
Q _{gd} (nC)	46				
Configuration	Single				

FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available



TO-220 FULLPAK



ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	vise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	60	V	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C		45		
	VGS at 10 V	$T_C = 100 ^{\circ}C$	ID	30	А	
Pulsed Drain Current ^a			I _{DM}	220		
Linear Derating Factor			0.32	W/°C		
Single Pulse Avalanche Energy ^b			E _{AS}	100	mJ	
Maximum Power Dissipation	T _C = 25 °C		PD	52	W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	- °C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 129 μ H, $R_G = 25 \Omega$, $I_{AS} = 30 \text{ A}$ (see fig. 12). c. $I_{SD} \leq 52 \text{ A}$, dI/dt $\leq 250 \text{ A}/\mu$ s, $V_{DD} \leq V_{DS}$, $T_J \leq 175 \text{ °C}$.

d. 1.6 mm from case.

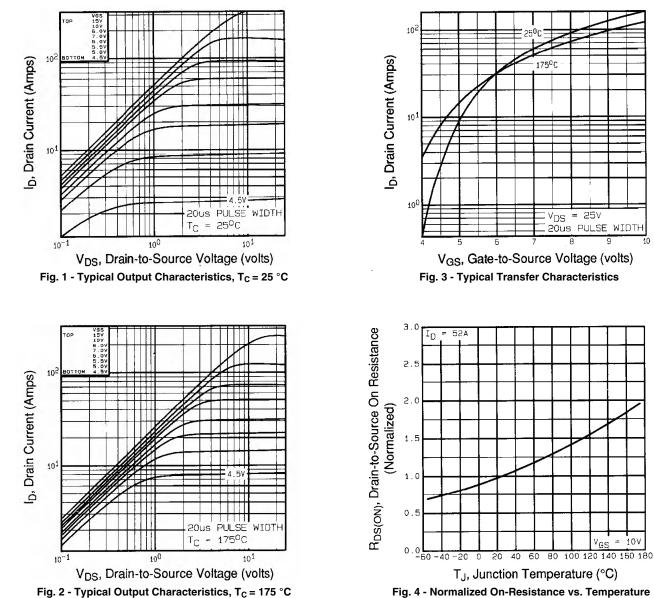


THERMAL RESISTANCE RAT	TINGS							
PARAMETER	SYMBOL	TYP. MAX.			UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 65				°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	- 3.1				°C/W		
	uplace others	viae poted						
SPECIFICATIONS $T_J = 25 \text{ °C}$, PARAMETER	SYMBOL	l.	T CONDITI		MIN.	TYP.	MAX.	UNI
Static	STMBOL	123	TCONDITI	0113	IVIIIN.	116.	WAA.	UNI
Drain-Source Breakdown Voltage	V _{DS}	V	0 1/ 1 2	50	60	-	-	v
V _{DS} Temperature Coefficient		$V_{GS} = 0 \text{ V}, \text{ I}_D = 250 \mu\text{A}$ Reference to 25 °C, I _D = 1 mA			00	- 0.060	-	v V/°C
50 1	$\Delta V_{DS}/T_J$				-	0.000		V/ C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$			1.0	-	3.0	-
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V			-	-	± 100	nA μA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$			-	-	25	
				T _J = 150 °C	-	-	250	~
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V		= 18 A ^b	-	0.027	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 25 V, I _D =	18 A ^D	15	-	-	S
Dynamic		1			1	1	r	1
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5 f = 1.0 MHz		-	1500	-	- pF	
Output Capacitance	C _{oss}			-	720	-		
Reverse Transfer Capacitance	C _{rss}			-	100	-		
Drain to Sink Capacitance	С			-	12	-		
Total Gate Charge	Qg				-	-	95	nC
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$		I _D = 52 A, V _{DS} = 48 V, see fig. 6 and 13 ^b	-	-	27	
Gate-Drain Charge	Q _{gd}		000		-	-	46	
Turn-On Delay Time	t _{d(on)}				-	19	-	
Rise Time	t _r	$\begin{array}{c} V_{DD} = 30 \; V, \; I_D = 52 \; A, \\ R_G = 9.1 \; \Omega, \; R_D = 0.54 \; \Omega, \\ \text{see fig. 10}^{\text{b}} \end{array}$		-	120	-	ns	
Turn-Off Delay Time	t _{d(off)}			-	55	-		
Fall Time	t _f			-	86	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH	
Internal Source Inductance	Ls			-	7.5	-		
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	45	A	
Pulsed Diode Forward Currenta	I _{SM}			-	-	120		
Body Diode Voltage	V _{SD}	$T_{\rm J}$ = 25 °C, I _S = 30 A, V _{GS} = 0 V ^b		-	-	2.5	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 52 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}^b$		-	140	300	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.2	2.8	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is do				ninated by	Ls and L	_D)

Notes

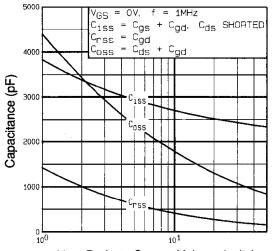
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





V_{DS}, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

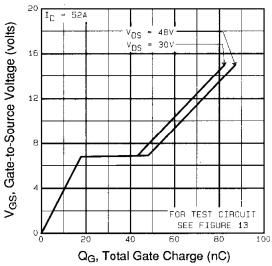


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

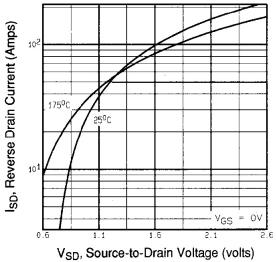
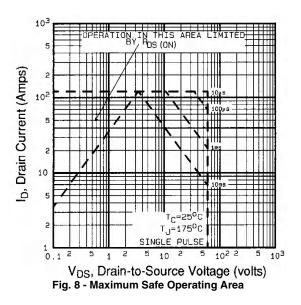


Fig. 7 - Typical Source-Drain Diode Forward Voltage





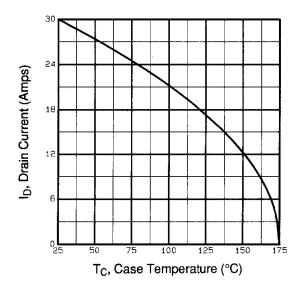


Fig. 9 - Maximum Drain Current vs. Case Temperature

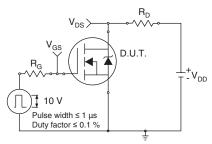


Fig. 10a - Switching Time Test Circuit

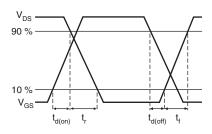


Fig. 10b - Switching Time Waveforms

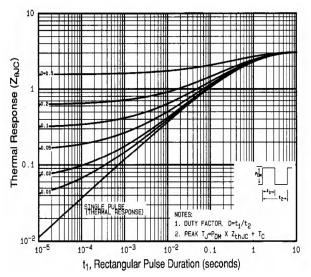
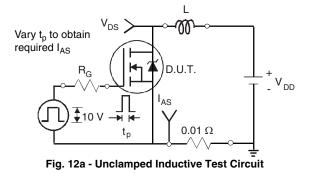


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



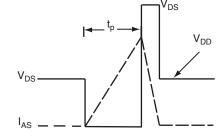
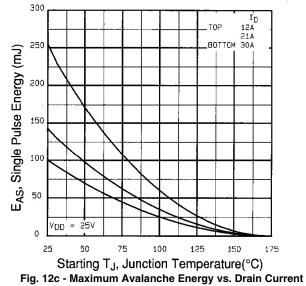
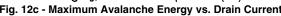


Fig. 12b - Unclamped Inductive Waveforms







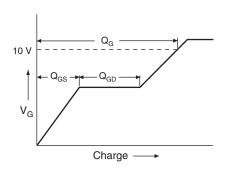
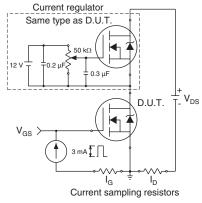
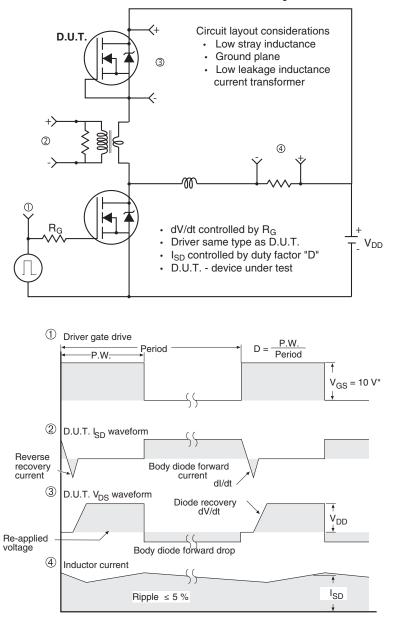


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



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